# 2SC3611

## Silicon NPN epitaxial planar type

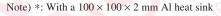
### For video amplifier

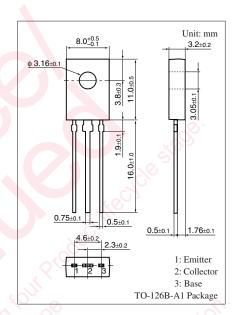
#### ■ Features

- High transition frequency f<sub>T</sub>
- Small collector output capacitance (Common base, input open circuited) C<sub>ob</sub>
- Wide current range
- TO-126B package which requires no insulation plate for installation to the heat sink

## ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Emitter open)	$V_{CBO}$	110	V	
Collector-emitter voltage	V <sub>CER</sub>	100	V	
(Resistor between B and E)				
Collector-emitter voltage (Base open)	V <sub>CEO</sub>	50	V	
Emitter-base voltage (Collector open)	V <sub>EBO</sub>	3.5	V	
Collector current	$I_{C}$	150	mA	
Peak collector current	I <sub>CP</sub>	300	mA	
Collector power dissipation	P <sub>C</sub>	1.2	W	
		4.0 *		
Junction temperature	$T_{j}$	150	°C	
Storage temperature	T <sub>stg</sub>	-55 to +150	°C Ø	



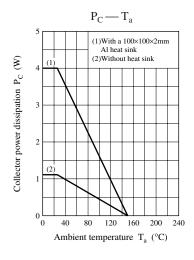


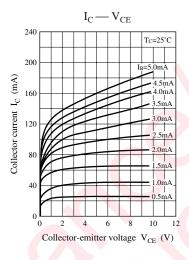
## ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

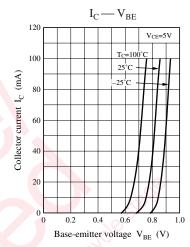
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V <sub>CBO</sub>	$I_C = 100 \mu\text{A},  I_E = 0$	110			V
Collector-emitter voltage (Resistor between B and E)	V <sub>CER</sub>	$I_C = 500 \ \mu A, R_{BE} = 470 \ \Omega$	100			V
Collector-emitter voltage (Base open)	V <sub>CEO</sub>	$I_C = 1 \text{ mA}, I_B = 0$	50			V
Emitter-base voltage (Collector open)	V <sub>EBO</sub>	$I_E = 100 \mu\text{A},  I_C = 0$	3.5			V
Collector-emitter cutoff current (Base open)	I <sub>CEO</sub>	$V_{CE} = 35 \text{ V}, I_{B} = 0$			10	μΑ
Forward current transfer ratio	h <sub>FE</sub>	$V_{CE} = 5 \text{ V}, I_{C} = 100 \text{ mA}$	20			_
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$			0.5	V
Transition frequency	f <sub>T1</sub>	$V_{CB} = 10 \text{ V}, I_E = -10 \text{ mA}, f = 200 \text{ MHz}$		300		MHz
	f <sub>T2</sub>	$V_{CB} = 10 \text{ V}, I_E = -110 \text{ mA}, f = 200 \text{ MHz}$		350		
Collector output capacitance (Common base, input open circuited)	C <sub>ob</sub>	$V_{CB} = 30 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		3		pF

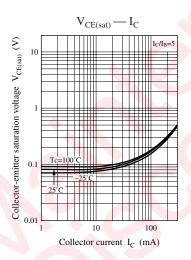
Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

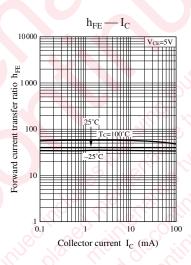
Publication date: January 2003 SJD00108BED 1

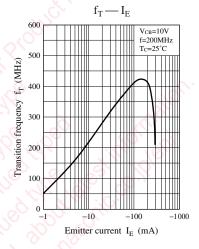


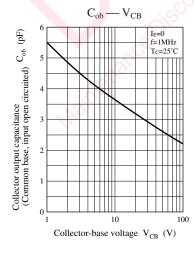


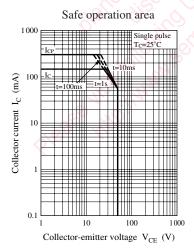




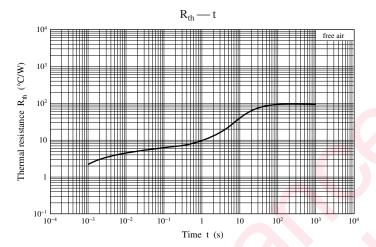








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